



ADVANCED PACKAGING

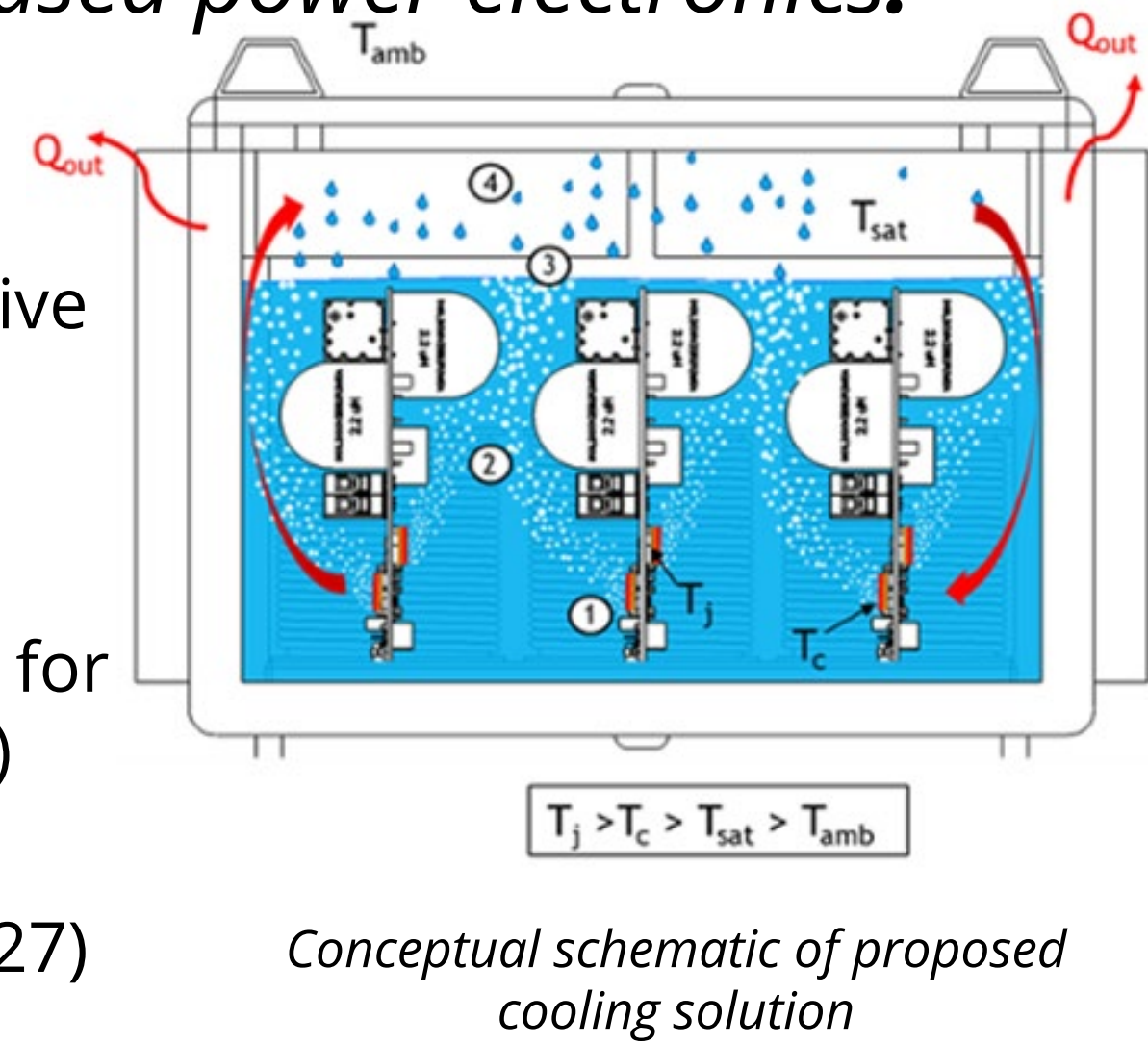
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OBJECTIVES

Develop an all encompassing, completely passive cooling solution for grid-level energy storage-based power electronics.

Primary Objectives

- **Model** candidate non-electrically conductive engineered fluids using advanced Finite Element Method boiling models (FY25)
- **Develop** a double-side cooled, flip-chip package with integrated finned heatsinks for the power semiconductor switches (FY26)
- **Design & fabricate** a 1 kW two-phase immersion cooling solution exemplar (FY27)



BACKGROUND

- Current immersion cooling used in advanced data centers utilize external heat exchanger and **pumped liquid cooling loop** to enable high power density (2-5 kW/m³).
- This method not directly applicable to grid integration since it:
 - Requires **significant maintenance** to ensure maximum performance.
 - **Lowers system lifetime** due to actively pumped thermal loop
- Previous Sandia-funded Laboratory Directed Research and Development project (#224288) developed preliminary tools and analysis for "system-as-a-heat pipe" concept
 - Correlations between critical heat flux, system pressure, and MOSFET junction temperature were developed

HYPOTHESIS, MOTIVATION, & IMPACT

To be implemented in remote areas that have harsh environmental conditions (e.g., New Mexico), Energy Storage Systems require very long (20 year) lifetimes, zero maintenance, and very low operational-costs.

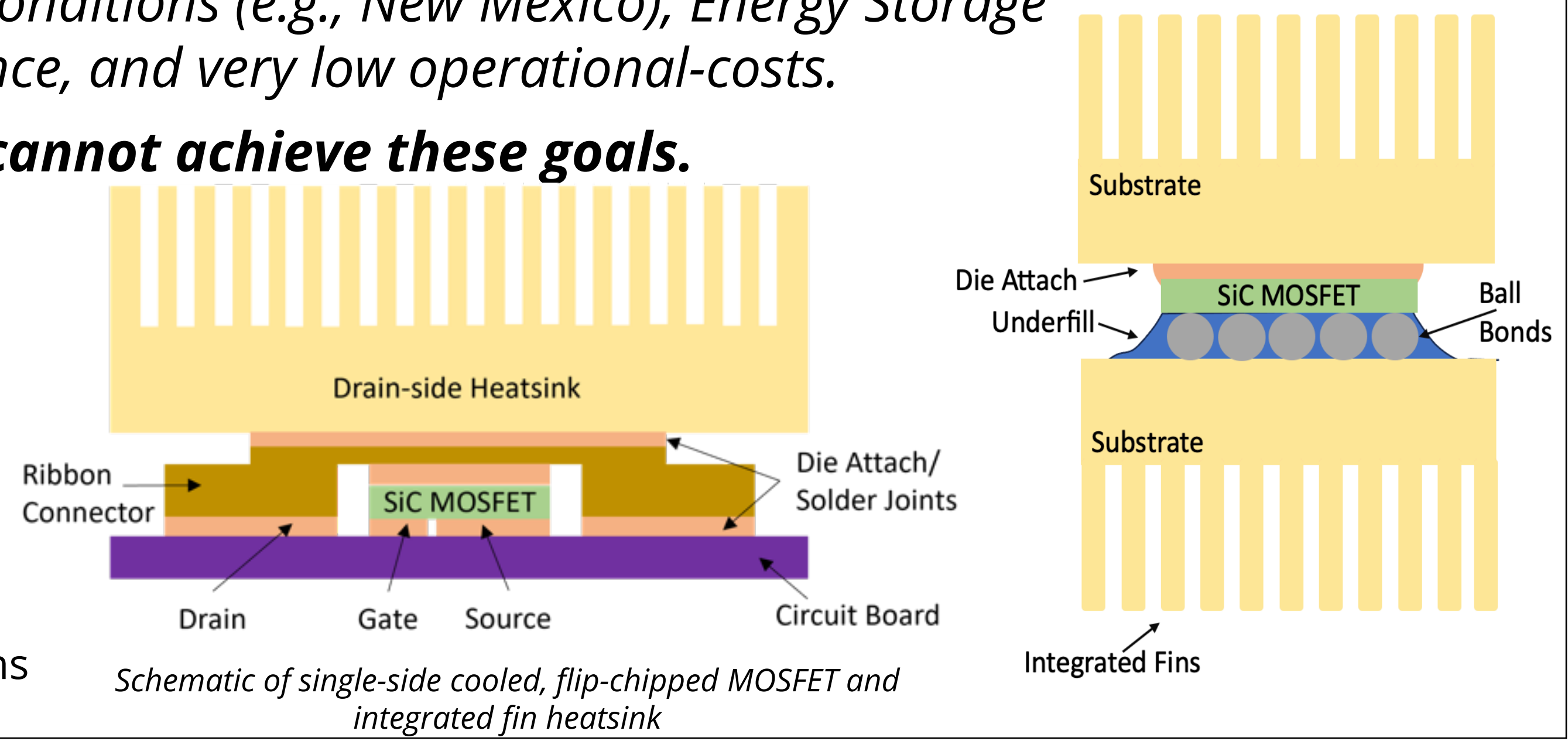
Typical Active Cooling methods (forced air/liquid) cannot achieve these goals.

Hypothesis

- Removal of heat exchanger and cooling loop while maintaining sufficient heat flux would **enable significantly more robust, cost-effective thermal management** for energy storage-based power electronics

Packaging Innovation

- Passive immersion cooling system requires double-side cooled, flip-chip package with integrated heatsinks for the power semiconductor switches.
- Package will maximize thermal dissipation with optimized size/layout of heatsink fins as determined by FEM models

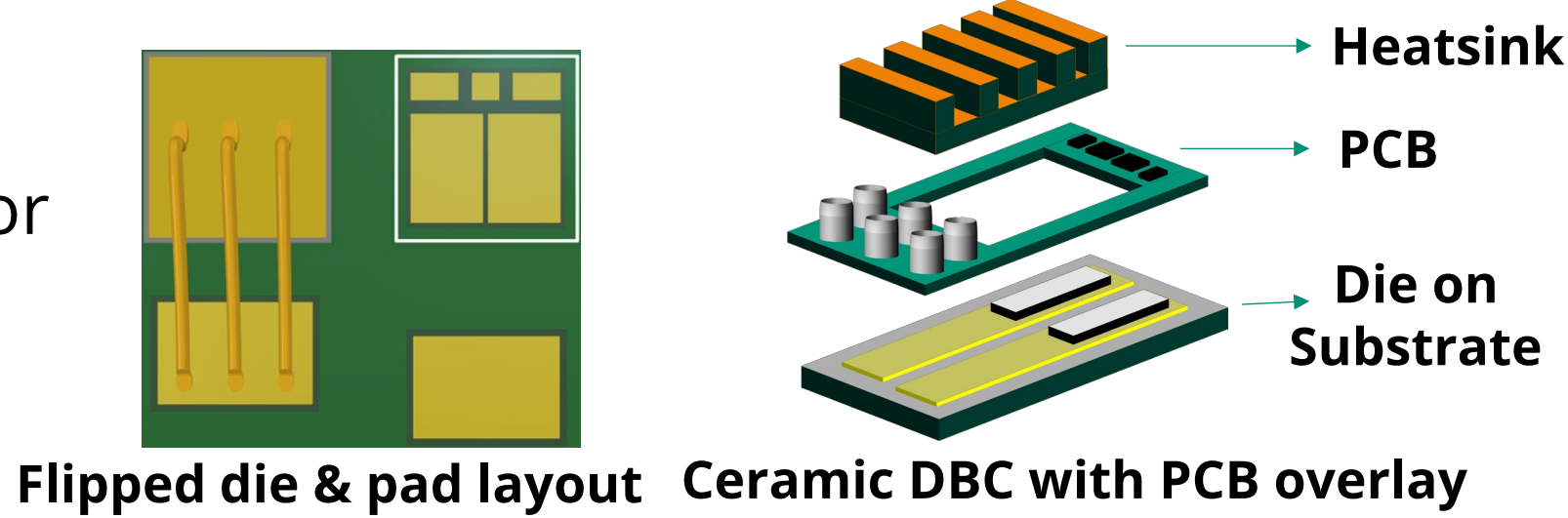


METHODOLOGY & TESTING

Design

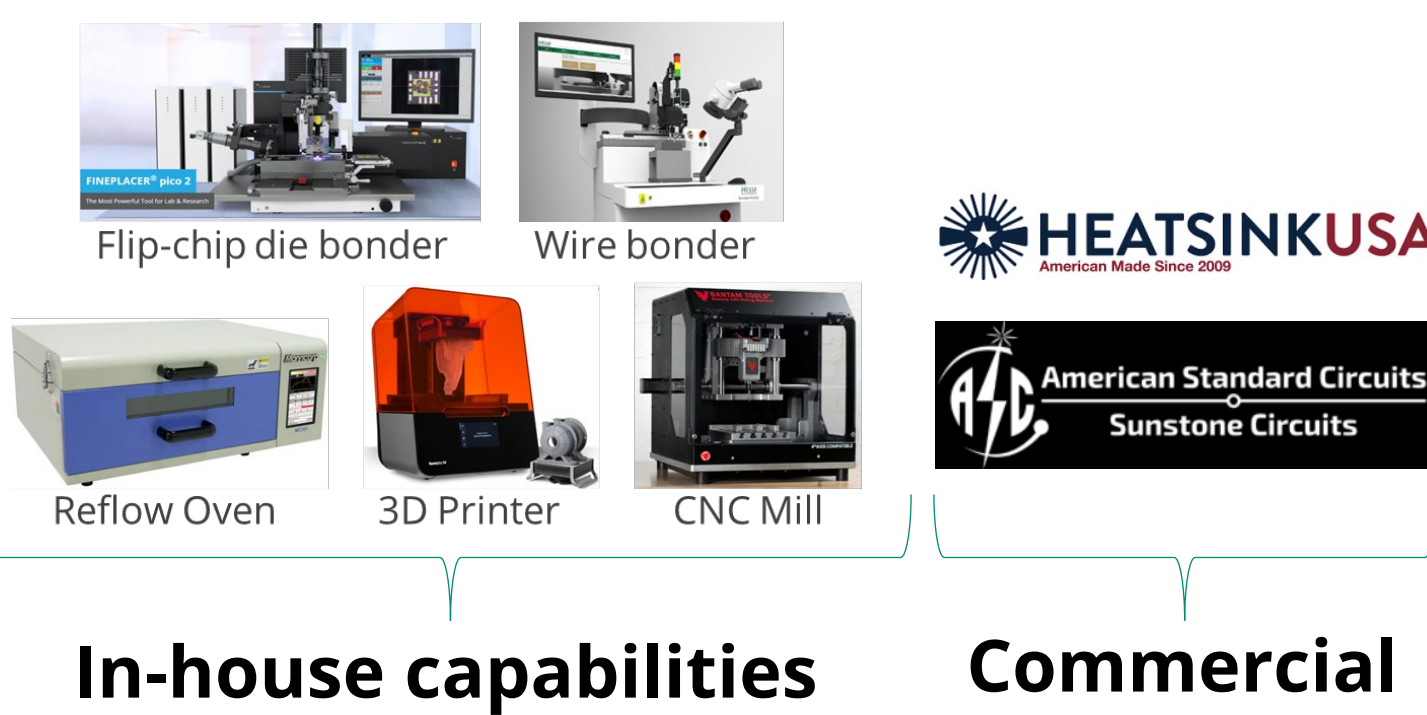
Develop in-house processes for flip chip bonding (FY25)

- Direct die-on-PCB
- Die on Direct Bond Copper (DBC) substrate



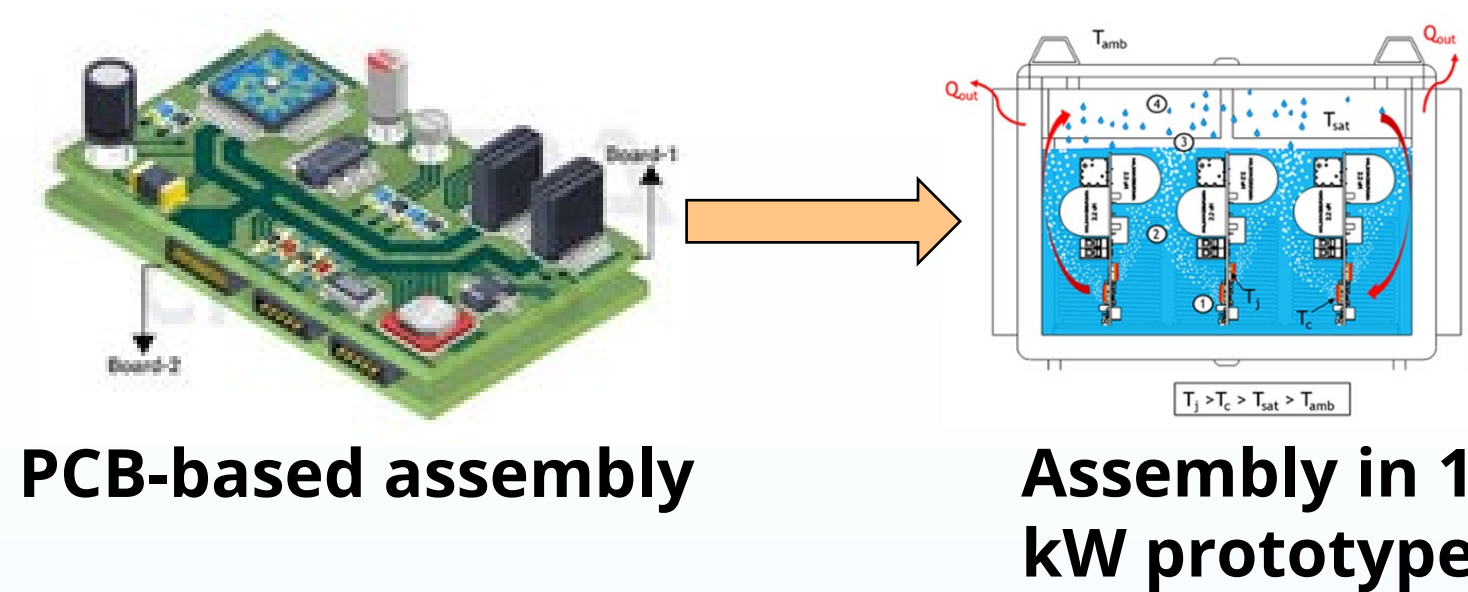
Fabricate

- Single-side cooled package (FY25)
- Double-side cooled package (FY26)
- Optimized heatsink (FY26)



Integrate

Double-side cooled module inserted into 1kW immersion cooled prototype (FY27)



Evaluate

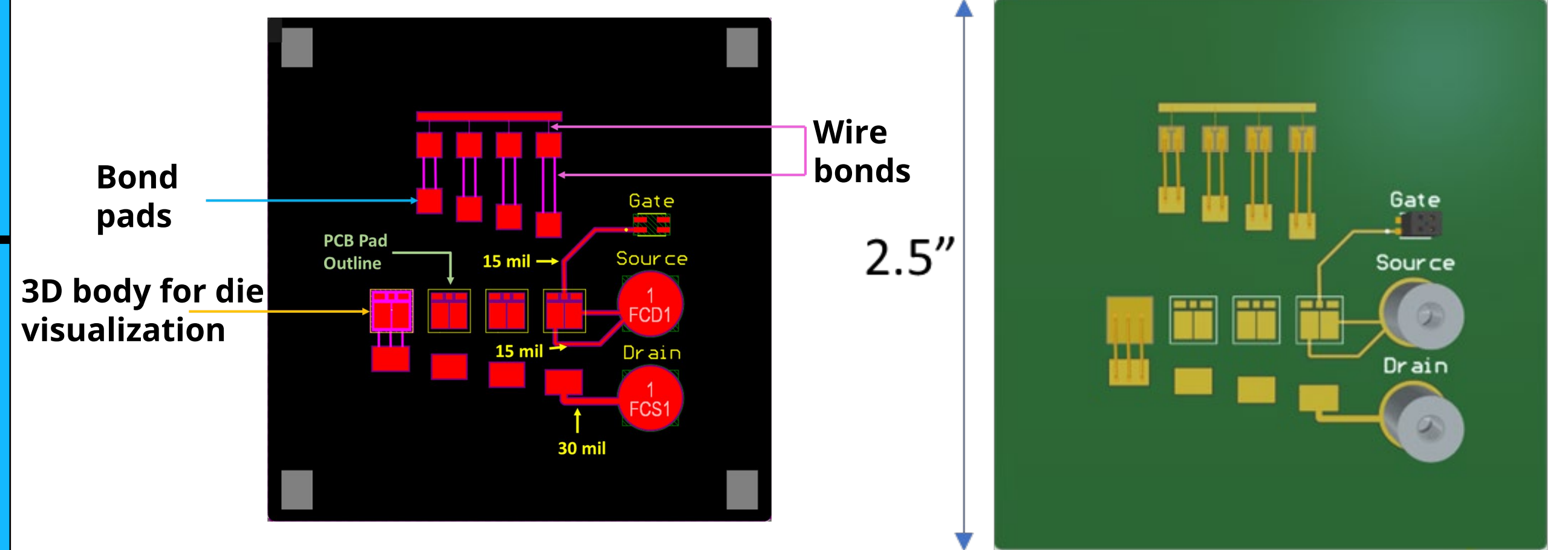
Electro-thermal Performance benchmark to active cooling (FY27)



RESULTS

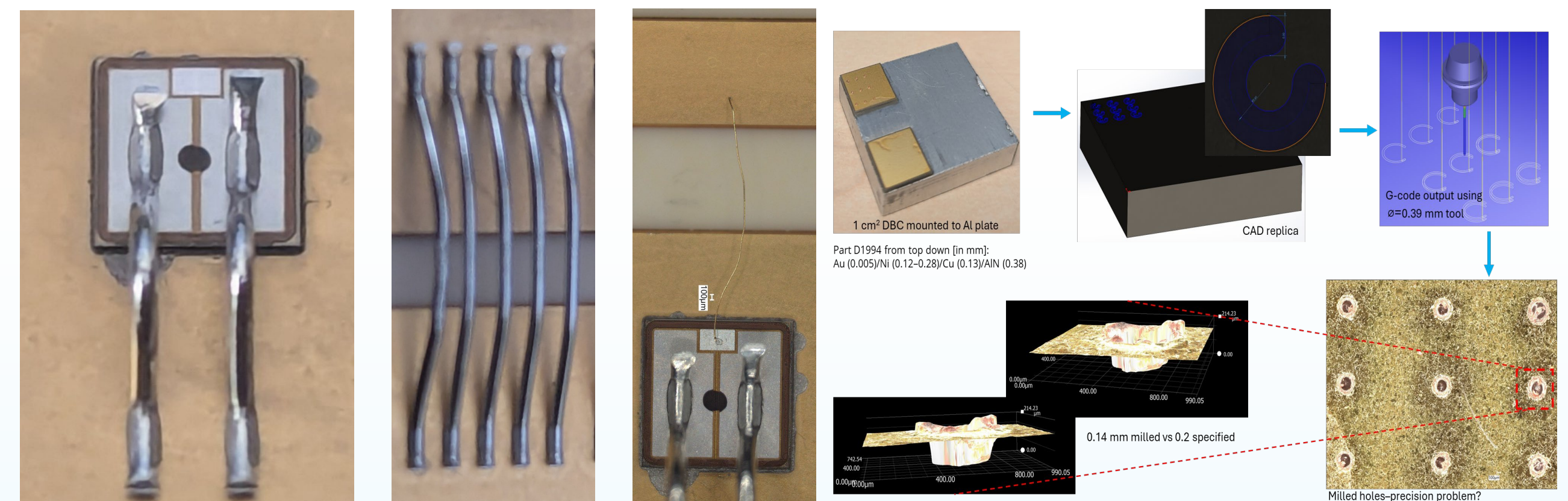
Process development PCB

Schematic of double-side cooled package



1. Determine process parameters for die and wire bonding on PCB
2. Evaluate electrical performance of flip-chipped die on board

Fabrication procedures



Initial results

1. Die attach, heavy-gauge wire, uniform array, and fine wire processes developed for DBC
2. DBC mounting on Al-block, G-code generation, hole array investigation for accuracy/uniformity of in-house manufacturing of custom DBCs